

<b>STN</b>	<b>Integrácia softvérového nástroja. Časť 5: Informačný model FDI.</b>	<b>STN EN 62769-5</b>
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Field Device Integration (FDI) - Part 5: FDI Information Model

Táto norma obsahuje anglickú verziu európskej normy.  
This standard includes the English version of the European Standard.

Táto norma bola označená vo Vestníku ÚNMS SR č. 11/15

Obsahuje: EN 62769-5:2015, IEC 62769-5:2015

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EUROPEAN STANDARD

**EN 62769-5**

NORME EUROPÉENNE

EUROPÄISCHE NORM

July 2015

ICS 25.040.40; 35.100

English Version

**Field Device Integration (FDI) - Part 5: FDI Information Model  
(IEC 62769-5:2015)**

Intégration des appareils de terrain (FDI) - Partie 5: Modèle  
d'Information FDI  
(IEC 62769-5:2015)

Feldgeräteintegration (FDI) - Teil 5: FDI-Informationsmodell  
(IEC 62769-5:2015)

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**European foreword**

The text of document 65E/348/CDV, future edition 1 of IEC 62769-5, prepared by SC 65E "Devices and integration in enterprise systems" of IEC/TC 65 "Industrial-process measurement, control and automation" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62769-5:2015.

The following dates are fixed:

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IEC/TR 62541-1 NOTE Harmonized as CLC/TR 62541-1.

IEC 62541-7 NOTE Harmonized as EN 62541-7

**Annex ZA**  
(normative)

**Normative references to international publications  
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NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: [www.cenelec.eu](http://www.cenelec.eu).

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61784-1	-	Industrial communication networks - Profiles -- Part 1: Fieldbus profiles	EN 61784-1	-
IEC 61804-3	-	Function blocks (FB) for process control and EDDL - Part 3: EDDL specification and communication profiles	-	-
IEC 62541-3	-	OPC unified architecture - Part 3: Address Space Model	EN 62541-3	-
IEC 62541-4	-	OPC Unified Architecture - Part 4: Services	EN 62541-4	-
IEC 62541-5	-	OPC unified architecture - Part 5: Information Model	EN 62541-5	-
IEC 62541-6	-	OPC unified architecture - Part 6: Mappings	EN 62541-6	-
IEC 62541-8	-	OPC Unified Architecture - Part 8: Data Access	EN 62541-8	-
IEC 62541-100	-	OPC unified architecture - Part 100: Device Interface	EN 62541-100	-
IEC 62769-1	-	Field device integration (FDI) - Part 1: Overview	-	-
IEC 62769-2	-	Field Device Integration (FDI) - Part 2: FDI - Client	-	-
IEC 62769-4	-	Field Device Integration (FDI) - Part 4: FDI - Packages	-	-
IEC 62769-7	-	Field Device Integration (FDI) - Part 7: FDI - Communication Devices	-	-



# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



**Field Device Integration (FDI) –  
Part 5: FDI Information Model**

**Intégration des appareils de terrain (FDI) –  
Partie 5: Modèle d'Information FDI**





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# INTERNATIONAL STANDARD

## NORME INTERNATIONALE



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**Field Device Integration (FDI) –  
Part 5: FDI Information Model**

**Intégration des appareils de terrain (FDI) –  
Partie 5: Modèle d'Information FDI**

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**FIELD DEVICE INTEGRATION (FDI) –****Part 5: FDI Information Model****FOREWORD**

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International Standard IEC 62769-5 has been prepared by subcommittee 65E: Devices and integration in enterprise systems, of IEC technical committee 65: Industrial-process measurement, control and automation.

The text of this standard is based on the following documents:

CDV	Report on voting
65E/348/CDV	65E/425/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62769 series, published under the general title *Field Device Integration (FDI)*, can be found on the IEC website.

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## INTRODUCTION

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- a) Method for the Supplying and Installation of Device-Specific Functionalities, see Patent Family DE10357276;
- b) Method and device for accessing a functional module of automation system, see Patent Family EP2182418;
- c) Methods and apparatus to reduce memory requirements for process control system software applications, see Patent Family US2013232186;
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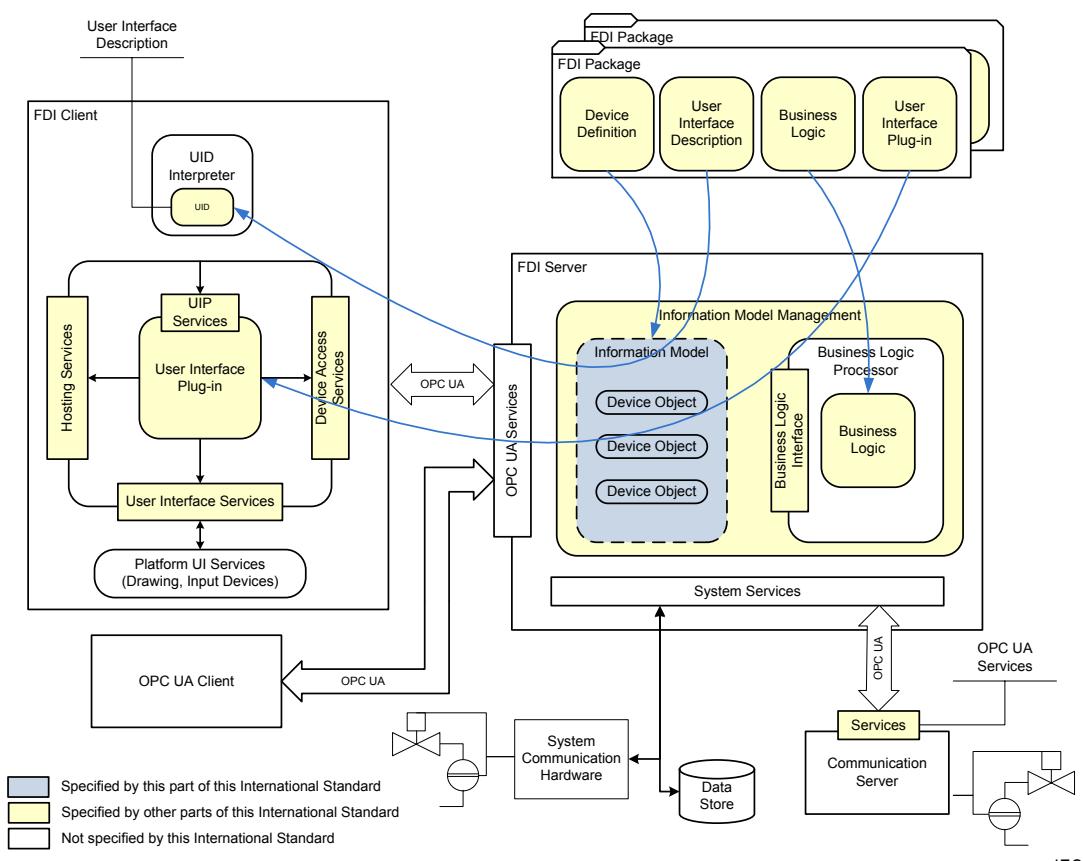
### Part 5: FDI Information Model

## 1 Scope

This part of IEC 62769 defines the FDI Information Model. One of the main tasks of the Information Model is to reflect the topology of the automation system. Therefore it represents the devices of the automation system as well as the connecting communication networks including their properties, relationships, and the operations that can be performed on them. The types in the AddressSpace of the FDI Server constitute some kind of catalogue, which is built from FDI Packages.

The fundamental types for the FDI Information Model are well defined in OPC UA for Devices (IEC 62541-100). The FDI Information Model specifies extensions for a few special cases and otherwise explains how these types are used and how the contents are built from elements of DevicePackages.

The overall FDI architecture is illustrated in Figure 1. The architectural components that are within the scope of this document have been highlighted in this illustration.



**Figure 1 – FDI architecture diagram**

## 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61784-1, *Industrial communication networks – Profiles – Part 1: Fieldbus profiles*

IEC 61804-3<sup>1</sup>, *Function blocks (FB) for process control and Electronic Device Description Language (EDDL) – Part 3: EDDL syntax and semantics*

IEC 62541-3, *OPC unified architecture – Part 3: Address Space Model*

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IEC 62541-8, *OPC unified architecture – Part 8: Data Access*

IEC 62541-100<sup>2</sup>, *OPC unified architecture – Part 100: OPC UA for Devices*

IEC 62769-1, *Field Device Integration (FDI) – Part 1: Overview*

NOTE IEC 62769-1 is technically identical to FDI-2021

IEC 62769-2, *Field Device Integration (FDI) – Part 2: FDI Client*

NOTE IEC 62769-2 is technically identical to FDI-2022

IEC 62769-4, *Field Device Integration (FDI) – Part 4: FDI Packages*

NOTE IEC 62769-4 is technically identical to FDI-2024

IEC 62769-7, *Field Device Integration (FDI) – Part 7: FDI Communication Devices*

NOTE IEC 62769-7 is technically identical to FDI-2027

koniec náhľadu – text d'alej pokračuje v platenej verzii STN

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<sup>1</sup> To be published.

<sup>2</sup> Under consideration.